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Contents

OTHER SPECTROSCOPIES AT NANOSCALE

Authors

Numbers in the index correspond to the last two digits of the six-digit citation identifier (CID) article numbering system used in Proceedings of SPIE. The first four digits reflect the volume number. Base 36 numbering is employed for the last two digits and indicates the order of articles within the volume. Numbers start with 00, 01, 02, 03, 04, 05, 06, 07, 08, 09, 0A, 0B...0Z, followed by 10-1Z, 20-2Z, etc.

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2 Surface-Enhanced Spectroscopy I
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3 Super Resolution Microscopy I
Thomas A. Klar, Johannes Kepler Universität Linz (Austria)

4 Tip-Enhanced Spectroscopy/Microscopy
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5 Super Resolution Microscopy II
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6 Surface-Enhanced Spectroscopy II
Prabhat Verma, Osaka University (Japan)
Alexander Egner, Laser-Laboratorium Göttingen e.V. (Germany)

7 Super Resolution Microscopy III
Clemens Kaminski, University of Cambridge (United Kingdom)

8 Other Spectroscopies at Nanoscale
Katsumasa Fujita, Osaka University (Japan)